

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination BAE ET AL.	
		Examiner Gopal C. Ray	Art Unit 2111	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,881,309	03-1999	Ohashi et al.	710/2
*	B	US-6,137,767	10-2000	Ro et al.	369/275.3
*	C	US-6,070,226	05-2000	Freeman et al.	711/117
*	D	US-5,511,055	04-1996	Otsuki et al.	720/649
*	E	US-6,542,917	04-2003	Watanabe et al.	708/605
*	F	US-6,928,595	08-2005	Takahashi et al.	714/718
*	G	US-5,025,339	06-1991	Kanno et al.	360/99.06
*	H	US-2003/0179667	09-2003	Yoshinaka et al.	369/44.41
*	I	US-6,400,566	06-2002	Ootori, Yasuhiro	361/695
*	J	US-6,744,445	06-2004	Goto et al.	715/719
*	K	US-2001/0009564	07-2001	Goto et al.	375/211
*	L	US-5,121,483	06-1992	Monahan et al.	710/40
*	M	US-2004/0190416	09-2004	Kakiuchi, Atsushi	369/053.11

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.